

# **SN54290, SN54293, SN54LS290, SN54LS293, SN74290, SN74293, SN74LS290, SN74LS293** **DECADE AND 4-BIT BINARY COUNTERS**

SDLS007 MARCH 1974 - REVISED MARCH 1988

'290, 'LS290 . . . DECADE COUNTERS  
'293, 'LS293 . . . 4-BIT BINARY COUNTERS

- GND and VCC on Corner Pins  
(Pins 7 and 14 Respectively)

## description

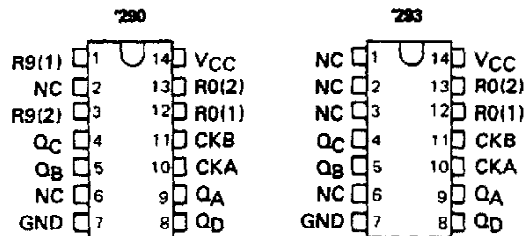
The SN54290/SN74290, SN54LS290/SN74LS290, SN54293/SN74293, and SN54LS293/SN74LS293 counters are electrically and functionally identical to the SN5490A/SN7490A, SN54LS90/SN74LS90, SN5493A/SN7493A, and SN54LS93/SN74LS93, respectively. Only the arrangement of the terminals has been changed for the '290, 'LS290, '293, and 'LS293.

Each of these monolithic counters contains four master-slave flip-flops and additional gating to provide a divide-by-two counter and a three-stage binary counter for which the count cycle length is divide-by-five for the '290 and 'LS290 and divide-by-eight for the '293 and 'LS293.

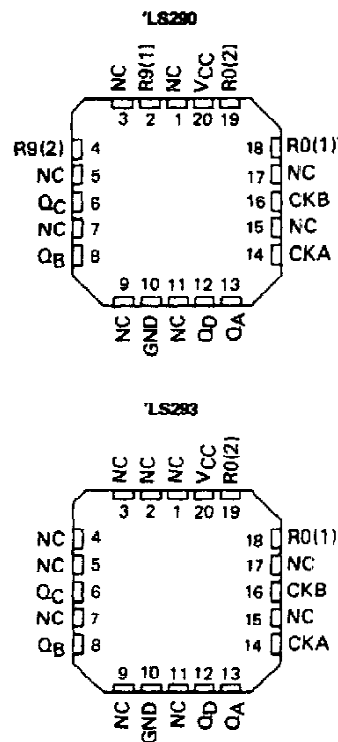
All of these counters have a gated zero reset and the '290 and 'LS290 also have gated set-to-nine inputs for use in BCD nine's complement applications.

To use the maximum count length (decade or four-bit binary) of these counters, the B input is connected to the Q<sub>A</sub> output. The input count pulses are applied to input A and the outputs are as described in the appropriate function table. A symmetrical divide-by-ten count can be obtained from the '290 and 'LS290 counters by connecting the Q<sub>D</sub> output to the A input and applying the input count to the B input which gives a divide-by-ten square wave at output Q<sub>A</sub>.

SN54290, SN54LS290, SN54293,  
SN54LS293 . . . J OR W PACKAGE  
SN74290, SN74293 . . . N PACKAGE  
SN74LS290, SN74LS293 . . . D OR N PACKAGE  
(TOP VIEW)



SN54LS290, SN54LS293 . . . FK PACKAGE  
(TOP VIEW)



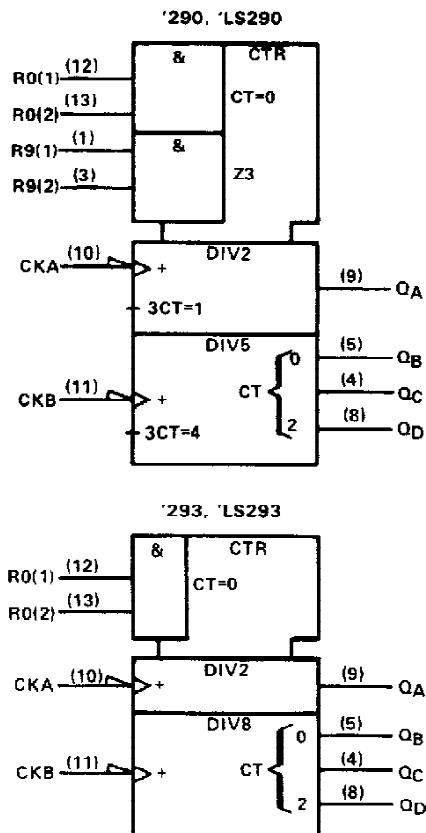
NC - No internal connection

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TEXAS  
INSTRUMENTS

**SN54290, SN54293, SN54LS290, SN54LS293,  
SN74290, SN74293, SN74LS290, SN74LS293  
DECADE AND 4-BIT BINARY COUNTERS**

logic symbols<sup>†</sup>



<sup>†</sup> These symbols are in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for D, J, N, and W packages.

**SN54290, SN54293, SN54LS290, SN54LS293,  
SN74290, SN74293, SN74LS290, SN74LS293  
DECADE AND 4-BIT BINARY COUNTERS**

**'290, 'LS290  
BCD COUNT SEQUENCE  
(See Note A)**

COUNT	OUTPUT			
	Q <sub>D</sub>	Q <sub>C</sub>	Q <sub>B</sub>	Q <sub>A</sub>
0	L	L	L	L
1	L	L	L	H
2	L	L	H	L
3	L	L	H	H
4	L	H	L	L
5	L	H	L	H
6	L	H	H	L
7	L	H	H	H
8	H	L	L	L
9	H	L	L	H

**'290, 'LS290  
BI-QUINARY (5-2)  
(See Note B)**

COUNT	OUTPUT			
	Q <sub>A</sub>	Q <sub>D</sub>	Q <sub>C</sub>	Q <sub>B</sub>
0	L	L	L	L
1	L	L	L	H
2	L	L	H	L
3	L	L	H	H
4	L	H	L	L
5	H	L	L	L
6	H	L	L	H
7	H	L	H	L
8	H	L	H	H
9	H	H	L	L

**'290, 'LS290  
RESET/COUNT FUNCTION TABLE**

RESET INPUTS				OUTPUT			
R <sub>0</sub> (1)	R <sub>0</sub> (2)	R <sub>9</sub> (1)	R <sub>9</sub> (2)	Q <sub>D</sub>	Q <sub>C</sub>	Q <sub>B</sub>	Q <sub>A</sub>
H	H	L	X	L	L	L	L
H	H	X	L	L	L	L	L
X	X	H	H	H	L	L	H
X	L	X	L	COUNT			
L	X	L	X	COUNT			
L	X	X	L	COUNT			
X	L	L	X	COUNT			

**'293, 'LS293  
COUNT SEQUENCE  
(See Note C)**

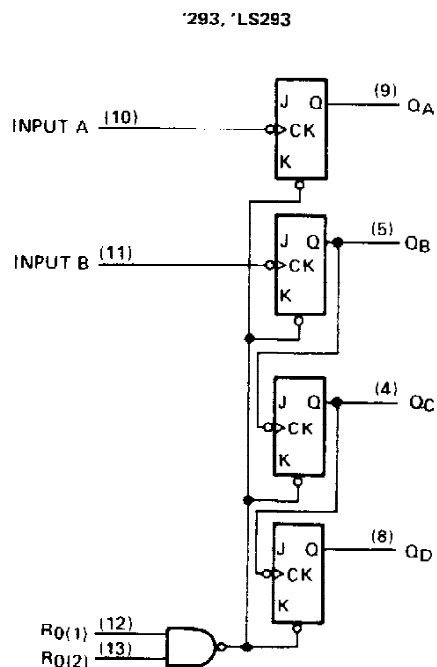
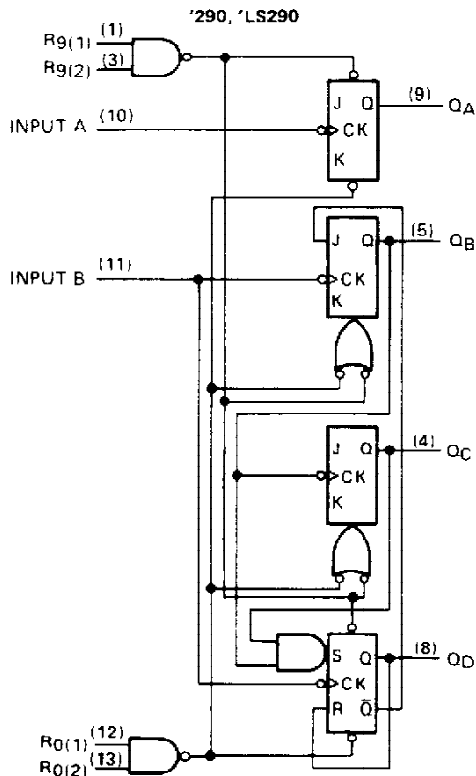
COUNT	OUTPUT			
	Q <sub>D</sub>	Q <sub>C</sub>	Q <sub>B</sub>	Q <sub>A</sub>
0	L	L	L	L
1	L	L	L	H
2	L	L	H	L
3	L	L	H	H
4	L	H	L	L
5	L	H	L	H
6	L	H	H	L
7	L	H	H	H
8	H	L	L	L
9	H	L	L	H
10	H	L	H	L
11	H	L	H	H
12	H	H	L	L
13	H	H	L	H
14	H	H	H	L
15	H	H	H	H

- NOTES: A. Output Q<sub>A</sub> is connected to input B for BCD count.  
B. Output Q<sub>D</sub> is connected to input A for bi-quinary count.  
C. Output Q<sub>A</sub> is connected to input B.  
D. H = high level, L = low level, X = irrelevant

**'293, 'LS293  
RESET/COUNT FUNCTION TABLE**

RESET INPUTS		OUTPUT			
R <sub>0</sub> (1)	R <sub>0</sub> (2)	Q <sub>D</sub>	Q <sub>C</sub>	Q <sub>B</sub>	Q <sub>A</sub>
H	H	L	L	L	L
L	X	COUNT			
X	L	COUNT			

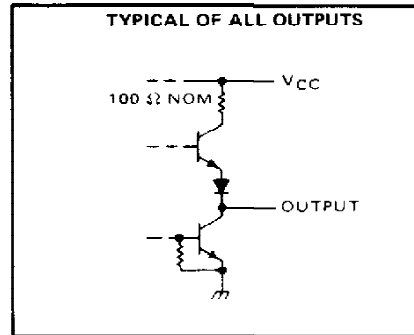
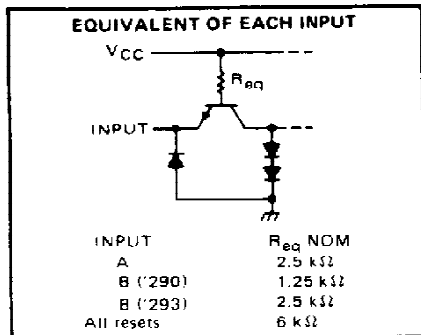
**logic diagrams (positive logic)**



Pin numbers shown are for D, J, N, and W packages.  
The J and K inputs shown without connection are for reference only and are functionally at a high level.

# **SN54290, SN54293, SN74290, SN74293** **DECADE AND 4-BIT BINARY COUNTERS**

## schematics of inputs and outputs



## absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, $V_{CC}$ (see Note 1)	7 V
Input voltage	5.5 V
Interemitter voltage (see Note 2)	5.5 V
Operating free-air temperature range: SN54' Circuits	-55°C to 125°C
SN74' Circuits	0°C to 70°C
Storage temperature range	-65°C to 150°C

NOTES: 1. Voltage values, except interemitter voltage, are with respect to network ground terminal.  
2. This is the voltage between two emitters of a multiple-emitter transistor. For these circuits, this rating applies between the two  $R_0$  inputs, and for the '290 circuit, it also applies between the two  $R_9$  inputs.

## recommended operating conditions

		SN54'			SN74'			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
Supply voltage, $V_{CC}$		4.5	5	5.5	4.75	5	5.25	V
High-level output current, $I_{OH}$		-800			-800			$\mu$ A
Low-level output current, $I_{OL}$		16			16			mA
Count frequency, $f_{count}$	A input	0		32	0		32	MHz
	B input	0		16	0		16	
Pulse width, $t_w$	A input	15			15			ns
	B input	30			30			
	Reset inputs	15			15			
Reset inactive-state setup time, $t_{su}$		25			25			ns
Operating free-air temperature, $T_A$		-55		125	0		70	C

# SN54290, SN54293, SN74290, SN74293 DECADE AND 4-BIT BINARY COUNTERS

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS†	'290			'293			UNIT
			MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V <sub>IH</sub>	High-level input voltage		2			2			V
V <sub>IL</sub>	Low-level input voltage				0.8			0.8	V
V <sub>IK</sub>	Input clamp voltage	V <sub>CC</sub> = MIN, I <sub>I</sub> = -12 mA			-1.5			-1.5	V
V <sub>OH</sub>	High-level output voltage	V <sub>CC</sub> = MIN, V <sub>IH</sub> = 2 V, V <sub>IL</sub> = 0.8 V, I <sub>OH</sub> = -800 µA	2.4	3.4		2.4	3.4		V
V <sub>OL</sub>	Low-level output voltage	V <sub>CC</sub> = MIN, V <sub>IH</sub> = 2 V, V <sub>IL</sub> = 0.8 V, I <sub>OL</sub> = 16 mA†		0.2	0.4		0.2	0.4	V
I <sub>I</sub>	Input current at maximum input voltage	V <sub>CC</sub> = MAX, V <sub>I</sub> = 5.5 V			1			1	mA
I <sub>IH</sub>	High-level input current	Any reset			40			40	µA
		A input			80			80	
		B input			120			80	
I <sub>IL</sub>	Low-level input current	Any reset			-1.6			-1.6	mA
		A input			-3.2			-3.2	
		B input			-4.8			-3.2	
I <sub>OS</sub>	Short-circuit output current‡	V <sub>CC</sub> = MAX	SN54†	-20	-57	SN54†	-20	-57	mA
			SN74†	-18	-57	SN74†	-18	-57	mA
I <sub>CC</sub>	Supply current	V <sub>CC</sub> = MAX, See Note 3		29	42		26	39	mA

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

‡ All typical values are at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C.

§ Not more than one output should be shorted at a time.

¶ Q<sub>A</sub> outputs are tested at I<sub>OL</sub> = 16 mA plus the limit value of I<sub>IL</sub> for the B input. This permits driving the B input while maintaining full fan-out capability.

NOTE 3: I<sub>CC</sub> is measured with all outputs open, both R<sub>0</sub> inputs grounded following momentary connection to 4.5 V, and all other inputs grounded.

switching characteristics, V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25°C

PARAMETER#	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	'290			'293			UNIT
				MIN	TYP	MAX	MIN	TYP	MAX	
f <sub>max</sub>	A	Q <sub>A</sub>	C <sub>L</sub> = 15 pF, R <sub>L</sub> = 400 Ω, See Note 4	32	42		32	42		MHz
	B	Q <sub>B</sub>		16			16			
t <sub>PLH</sub>	A	Q <sub>A</sub>			10	16		10	16	ns
t <sub>PHL</sub>					12	18		12	18	
t <sub>PLH</sub>	A	Q <sub>D</sub>			32	48		46	70	ns
t <sub>PHL</sub>					34	50		46	70	
t <sub>PLH</sub>	B	Q <sub>B</sub>			10	16		10	16	ns
t <sub>PHL</sub>					14	21		14	21	
t <sub>PLH</sub>	B	Q <sub>C</sub>			21	32		21	32	ns
t <sub>PHL</sub>					23	35		23	35	
t <sub>PLH</sub>	B	Q <sub>D</sub>			21	32		34	51	ns
t <sub>PHL</sub>					23	35		34	51	
t <sub>PHL</sub>	Set-to-0	Any			26	40		26	40	ns
t <sub>PLH</sub>	Set-to-0	Q <sub>A</sub> , Q <sub>D</sub>			20	30				ns
t <sub>PHL</sub>		Q <sub>B</sub> , Q <sub>C</sub>			26	40				

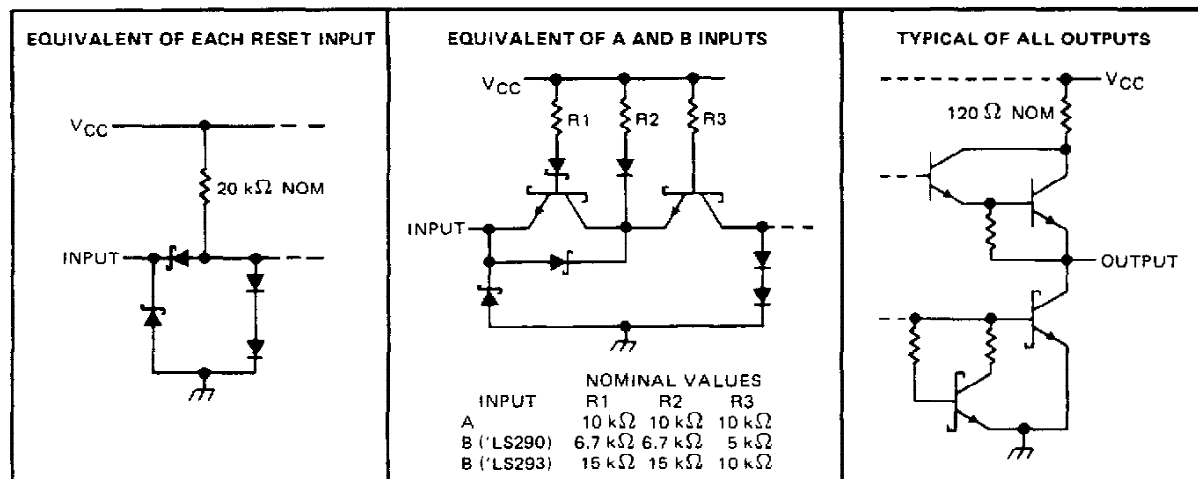
# f<sub>max</sub> = maximum count frequency

t<sub>PLH</sub> = propagation delay time, low-to-high-level output

t<sub>PHL</sub> = propagation delay time, high-to-low-level output

NOTE 4: Load circuits and voltage waveforms are shown in Section 1.

### schematics of inputs and outputs



Supply voltage, $V_{CC}$ (see Note 5)	7 V
Input voltage: R inputs	7 V
A and B inputs	5.5 V
Operating free-air temperature range: SN54LS290, SN54LS293	–55°C to 125°C
SN74LS290, SN74LS293	0°C to 70°C
Storage temperature range	–65°C to 150°C

NOTE 5: Voltage values are with respect to network ground terminal.

**recommended operating conditions**

		SN54LS'			SN74LS'			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	
Supply voltage, $V_{CC}$		4.5	5	5.5	4.75	5	5.25	V
High-level output current, $I_{OH}$		-400			-400			$\mu A$
Low-level output current, $I_{OL}$		4			8			mA
Count frequency, $f_{count}$	A input	0	32		0	32		MHz
	B input	0	16		0	16		
Pulse width, $t_W$	A input	15			15			ns
	B input	30			30			
	Reset inputs	30			30			
Reset inactive-state setup time, $t_{SU}$		25			25			ns
Operating free-air temperature, $T_A$		-55	125		0	70		$^{\circ}C$

# SN54LS290, SN54LS293, SN74LS290, SN74LS293

## DECADE AND 4-BIT BINARY COUNTERS

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS†	SN54LS'			SN74LS'			UNIT
			MIN	TYP‡	MAX	MIN	TYP‡	MAX	
V <sub>IH</sub>	High-level input voltage		2			2			V
V <sub>IL</sub>	Low-level input voltage				0.7			0.8	V
V <sub>IK</sub>	Input clamp voltage	V <sub>CC</sub> = MIN, I <sub>I</sub> = -18 mA			-1.5			-1.5	V
V <sub>OH</sub>	High-level output voltage	V <sub>CC</sub> = MIN, V <sub>IH</sub> = 2 V, V <sub>IL</sub> = V <sub>IL</sub> max, I <sub>OH</sub> = -400 µA	2.5	3.4		2.7	3.4		V
V <sub>OL</sub>	Low-level output voltage	V <sub>CC</sub> = MIN, V <sub>IH</sub> = 2 V, V <sub>IL</sub> = V <sub>IL</sub> max							V
		I <sub>OL</sub> = 4 mA¶ I <sub>OL</sub> = 8 mA¶	0.25	0.4	0.25	0.4	0.35	0.5	
I <sub>I</sub>	Input current at maximum input voltage	Any reset	V <sub>CC</sub> = MAX, V <sub>I</sub> = 7 V			0.1			mA
		A input				0.2			
		B of 'LS290	V <sub>CC</sub> = MAX, V <sub>I</sub> = 5.5 V			0.4			
		B of 'LS293				0.2			
I <sub>IH</sub>	High-level input current	Any reset				20			µA
		A input	V <sub>CC</sub> = MAX, V <sub>I</sub> = 2.7 V			40			
		B of 'LS290				80			
		B of 'LS293				40			
I <sub>IL</sub>	Low-level input current	Any reset				-0.4			mA
		A input	V <sub>CC</sub> = MAX, V <sub>I</sub> = 0.4 V			-2.4			
		B of 'LS290				-3.2			
		B of 'LS293				-1.6			
I <sub>OS</sub>	Short-circuit output current§	V <sub>CC</sub> = MAX	-20		-100	-20		-100	mA
I <sub>CC</sub>	Supply current	V <sub>CC</sub> = MAX, See Note 3	'LS290			9 15			mA
			'LS293			9 15			

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

‡ All typical values are at V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25° C.

§ Not more than one output should be shorted at a time, and duration of the short-circuit should not exceed one second.

¶ Q<sub>A</sub> outputs are tested at specified I<sub>OL</sub> plus the limit value of I<sub>IL</sub> for the B input. This permits driving the B input while maintaining full fan-out capability.

NOTE 3: I<sub>CC</sub> is measured with all outputs open, both R<sub>G</sub> inputs grounded following momentary connection to 4.5 V, and all other inputs grounded.

switching characteristics, V<sub>CC</sub> = 5 V, T<sub>A</sub> = 25° C

PARAMETER#	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	'LS290			'LS293			UNIT
				MIN	TYP	MAX	MIN	TYP	MAX	
f <sub>max</sub>	A	Q <sub>A</sub>	C <sub>L</sub> = 15 pF, R <sub>L</sub> = 2 kΩ, See Note 4	32	42		32	42		MHz
	B	Q <sub>B</sub>		16			16			
t <sub>PLH</sub>	A	Q <sub>A</sub>		10	16		10	16		ns
t <sub>PHL</sub>				12	18		12	18		
t <sub>PLH</sub>	A	Q <sub>D</sub>		32	48		46	70		ns
t <sub>PHL</sub>				34	50		46	70		
t <sub>PLH</sub>	B	Q <sub>B</sub>		10	16		10	16		ns
t <sub>PHL</sub>				14	21		14	21		
t <sub>PLH</sub>	B	Q <sub>C</sub>		21	32		21	32		ns
t <sub>PHL</sub>				23	35		23	35		
t <sub>PLH</sub>	B	Q <sub>D</sub>		21	32		34	51		ns
t <sub>PHL</sub>				23	35		34	51		
t <sub>PHL</sub>	Set to 0	Any		26	40		26	40		ns
t <sub>PLH</sub>	Set to 9	Q <sub>A</sub> , Q <sub>D</sub>		20	30					ns
t <sub>PHL</sub>		Q <sub>B</sub> , Q <sub>C</sub>		26	40					

# f<sub>max</sub> = maximum count frequency

t<sub>PLH</sub> = propagation delay time, low-to-high-level output

t<sub>PHL</sub> = propagation delay time, high-to-low-level output

NOTE 4: Load circuits and voltage waveforms are shown in Section 1.

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